

<b>Notice of References Cited</b>	Application/Control No. 10/660,176	Applicant(s)/Patent Under Reexamination MUDERLAK ET AL.	
	Examiner Frederick C. Nicolas	Art Unit 3754	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,467,651	10-2002	Muderlak et al.	222/52
	B	US-1,229,556	06-1917	Watrous	222/180
	C	US-6,142,342	11-2000	Lewis, Richard P.	222/180
	D	US-6,003,170	12-1999	Humpert et al.	4/623
	E	US-6,202,980	03-2001	Vincent et al.	251/129.04
	F	US-5,595,216	01-1997	Pilolla, Joseph J.	137/607
	G	US-RE37,888	10-2002	Cretu-Petra, Eugen	236/12.12
	H	US-6,119,901	09-2000	Hanna, Emmanuel A.	222/321.1
	I	US-6,085,784	07-2000	Bloom et al.	137/606
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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